

MOSFET

StrongIRFET™ 2 Power-Transistor, 30 V

Features

- Optimized for a wide range of applications
- N-channel, logic level
- 100% avalanche tested
- 175°C rated
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21

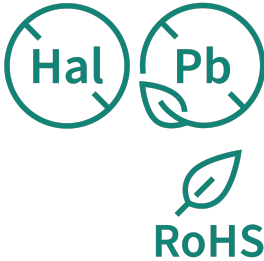
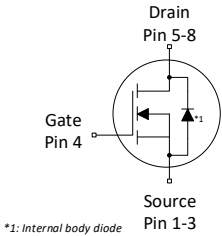
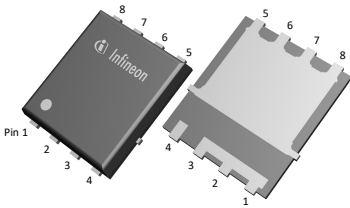
Product validation

Qualified according to JEDEC Standard

Table 1 Key performance parameters

Parameter	Value	Unit
$V_{DS}$	30	V
$R_{DS(on),max}$	2.8	mΩ
$I_D$	128	A
$Q_{oss}$	21	nC
$Q_g (0V..4.5V)$	13	nC

PG-TDSON-8



Type / Ordering code	Package	Marking	Related links
ISC028N03LF2S	PG-TDSON-8	028N03F2	-



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## 1 Maximum ratings

at  $T_A=25\text{ °C}$ , unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Continuous drain current <sup>1)</sup>	$I_D$	-	-	128 90 24	A	$V_{GS}=10\text{ V}$ , $T_C=25\text{ °C}$ $V_{GS}=10\text{ V}$ , $T_C=100\text{ °C}$ $V_{GS}=10\text{ V}$ , $T_A=25\text{ °C}$ , $R_{THJA}=50\text{ °C/W}$ <sup>2)</sup>
Pulsed drain current <sup>3)</sup>	$I_{D,pulse}$	-	-	512	A	$T_C=25\text{ °C}$
Avalanche energy, single pulse <sup>4)</sup>	$E_{AS}$	-	-	68 136	mJ	$I_D=50\text{ A}$ , $R_{GS}=25\text{ }\Omega$ $I_D=25\text{ A}$ , $R_{GS}=25\text{ }\Omega$
Gate source voltage	$V_{GS}$	-20	-	20	V	-
Power dissipation	$P_{tot}$	-	-	83 3.0	W	$T_C=25\text{ °C}$ $T_A=25\text{ °C}$ , $R_{THJA}=50\text{ °C/W}$ <sup>2)</sup>
Operating and storage temperature	$T_j, T_{stg}$	-55	-	175	°C	-

<sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

<sup>2)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

<sup>3)</sup> See Diagram 3 for more detailed information

<sup>4)</sup> See Diagram 13 for more detailed information

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case, bottom	$R_{thJC}$	-	-	1.8	°C/W	-
Thermal resistance, junction - case, top	$R_{thJC}$	-	-	20	°C/W	
Thermal resistance, junction - ambient, 6 cm <sup>2</sup> cooling area <sup>5)</sup>	$R_{thJA}$	-	-	50	°C/W	

<sup>5)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

### 3 Electrical characteristics

at  $T_j=25\text{ °C}$ , unless otherwise specified

**Table 4 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	30	-	-	V	$V_{GS}=0\text{ V}$ , $I_D=1\text{ mA}$
Gate threshold voltage	$V_{GS(th)}$	1.35	1.85	2.35	V	$V_{DS}=V_{GS}$ , $I_D=30\text{ }\mu\text{A}$
Zero gate voltage drain current	$I_{DSS}$	-	0.1 10	1 100	$\mu\text{A}$	$V_{DS}=30\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=25\text{ °C}$ $V_{DS}=30\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=125\text{ °C}$
Gate-source leakage current	$I_{GSS}$	-	10	100	nA	$V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	2.35 3.14	2.8 4.5	m $\Omega$	$V_{GS}=10\text{ V}$ , $I_D=50\text{ A}$ $V_{GS}=4.5\text{ V}$ , $I_D=25\text{ A}$
Gate resistance	$R_G$	-	2.4	-	$\Omega$	-
Transconductance <sup>6)</sup>	$g_{fs}$	60	-	-	S	$ V_{DS} \geq 2 I_D R_{DS(on)max}$ , $I_D=50\text{ A}$

<sup>6)</sup> Defined by design. Not subject to production test.

**Table 5 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Input capacitance	$C_{iss}$	-	1780	-	pF	$V_{GS}=0\text{ V}$ , $V_{DS}=15\text{ V}$ , $f=1\text{ MHz}$
Output capacitance	$C_{oss}$	-	360	-	pF	
Reverse transfer capacitance	$C_{rss}$	-	100	-	pF	
Turn-on delay time	$t_{d(on)}$	-	13	-	ns	$V_{DD}=15\text{ V}$ , $V_{GS}=4.5\text{ V}$ , $I_D=50\text{ A}$ , $R_{G,ext}=1.6\text{ }\Omega$
Rise time	$t_r$	-	5.8	-	ns	
Turn-off delay time	$t_{d(off)}$	-	12	-	ns	
Fall time	$t_f$	-	6.8	-	ns	

**Table 6 Gate charge characteristics <sup>7)</sup>**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Gate to source charge	$Q_{gs}$	-	6.2	-	nC	$V_{DD}=15\text{ V}$ , $I_D=50\text{ A}$ , $V_{GS}=0\text{ to }4.5\text{ V}$
Gate charge at threshold	$Q_{g(th)}$	-	3.3	-	nC	
Gate to drain charge	$Q_{gd}$	-	4.1	-	nC	
Switching charge	$Q_{sw}$	-	6.9	-	nC	
Gate charge total <sup>8)</sup>	$Q_g$	-	13	19	nC	
Gate plateau voltage	$V_{plateau}$	-	3.5	-	V	$V_{DD}=15\text{ V}$ , $I_D=50\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$
Gate charge total <sup>8)</sup>	$Q_g$	-	27	41	nC	

**Table 6 Gate charge characteristics** <sup>7)</sup>

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Gate charge total, sync. FET <sup>8)</sup>	$Q_{g(sync)}$	-	11	-	nC	$V_{DS}=0.1\text{ V}$ , $V_{GS}=0\text{ to }4.5\text{ V}$
Output charge <sup>8)</sup>	$Q_{oss}$	-	21	-	nC	$V_{DS}=15\text{ V}$ , $V_{GS}=0\text{ V}$

<sup>7)</sup> See "Gate charge waveforms" for parameter definition

<sup>8)</sup> Defined by design. Not subject to production test.

**Table 7 Reverse diode**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Diode continuous forward current	$I_S$	-	-	80	A	$T_C=25\text{ °C}$
Diode pulse current	$I_{S,pulse}$	-	-	512	A	
Diode forward voltage	$V_{SD}$	-	0.83	1.0	V	$V_{GS}=0\text{ V}$ , $I_F=50\text{ A}$ , $T_J=25\text{ °C}$
Reverse recovery time	$t_{rr}$	-	16	-	ns	$V_R=15\text{ V}$ , $I_F=50\text{ A}$ , $di_F/dt=500\text{ A}/\mu\text{s}$
Reverse recovery charge	$Q_{rr}$	-	39	-	nC	

4 Electrical characteristics diagrams

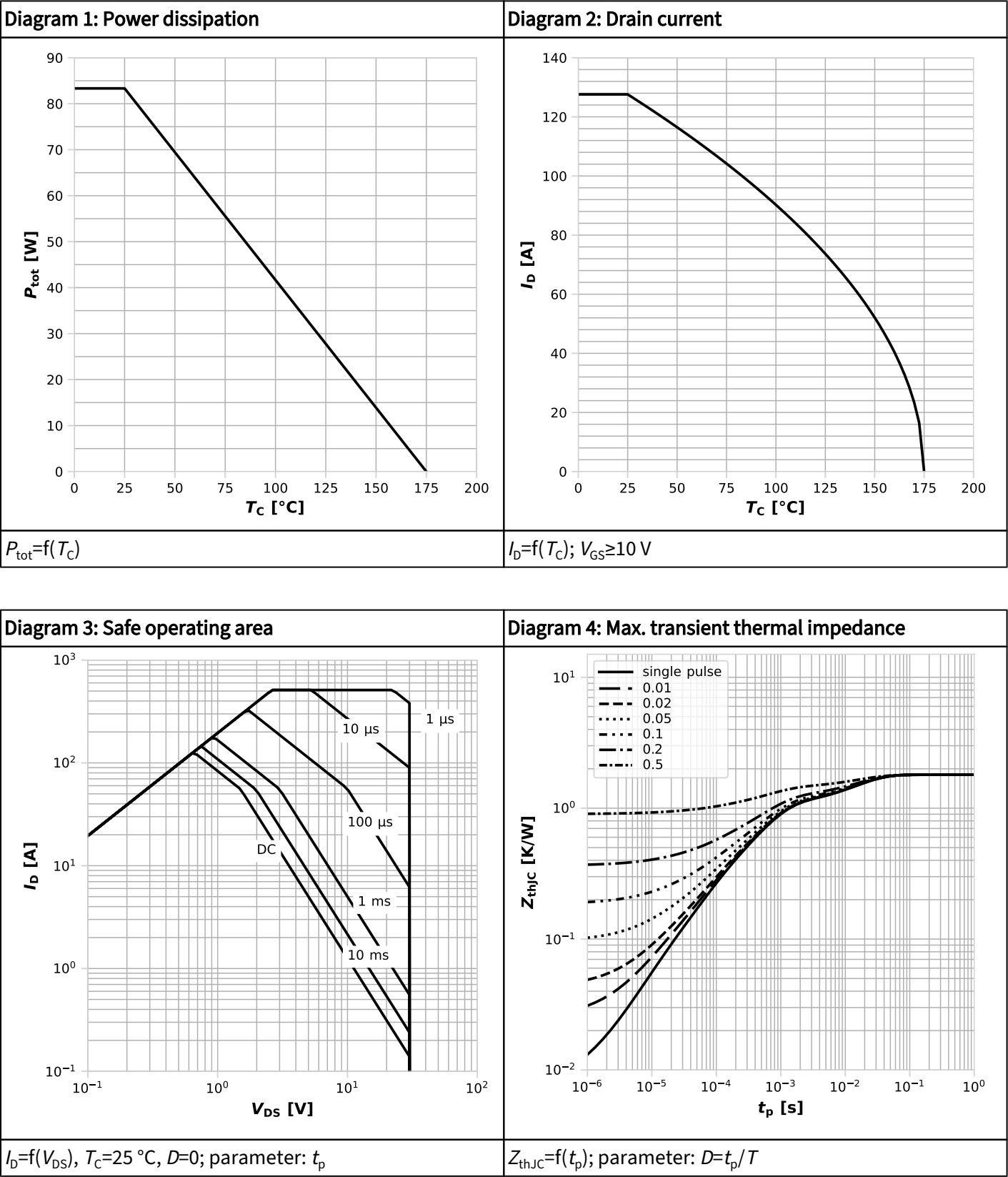
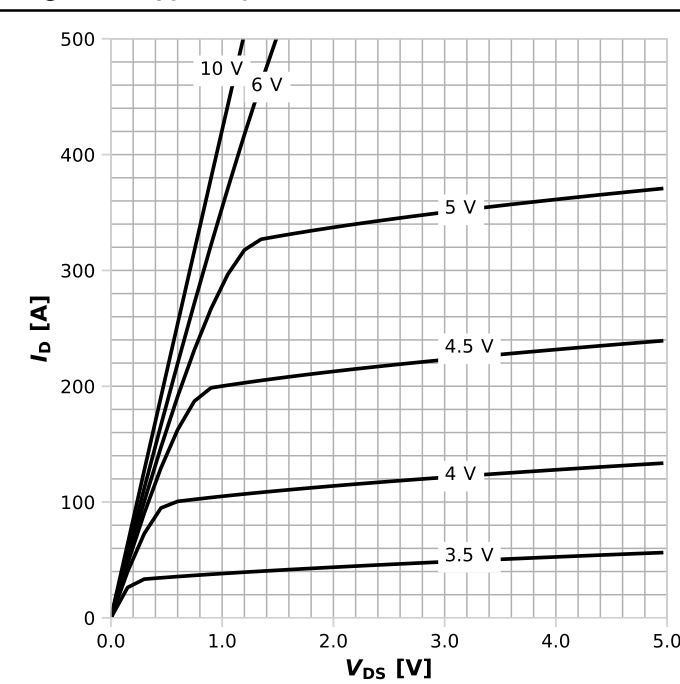
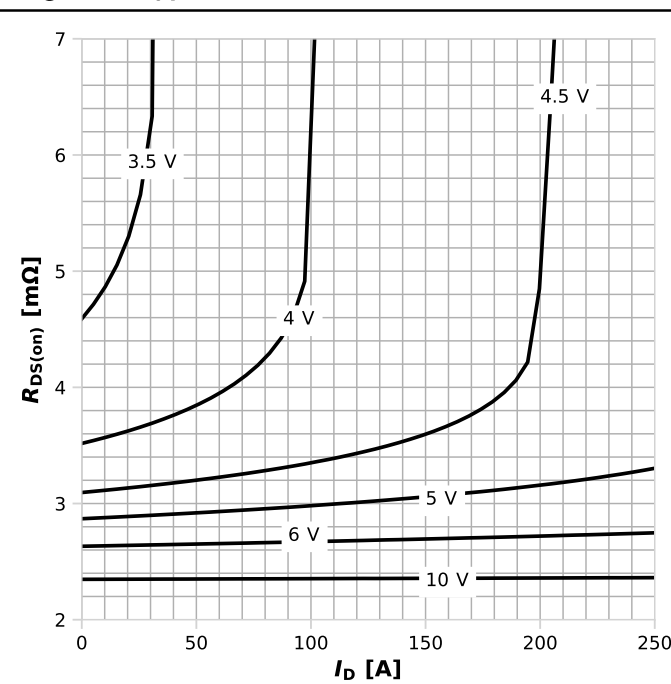


Diagram 5: Typ. output characteristics



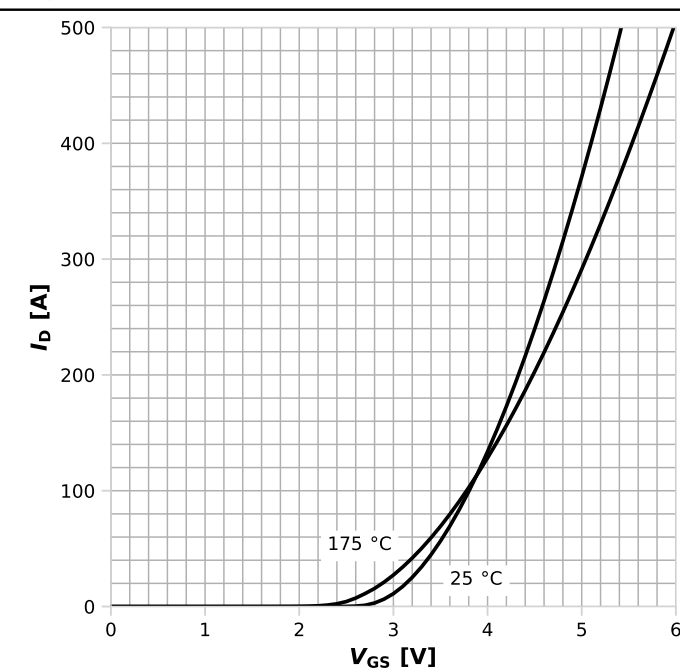
$I_D = f(V_{DS})$ ,  $T_j = 25^\circ\text{C}$ ; parameter:  $V_{GS}$

Diagram 6: Typ. drain-source on resistance



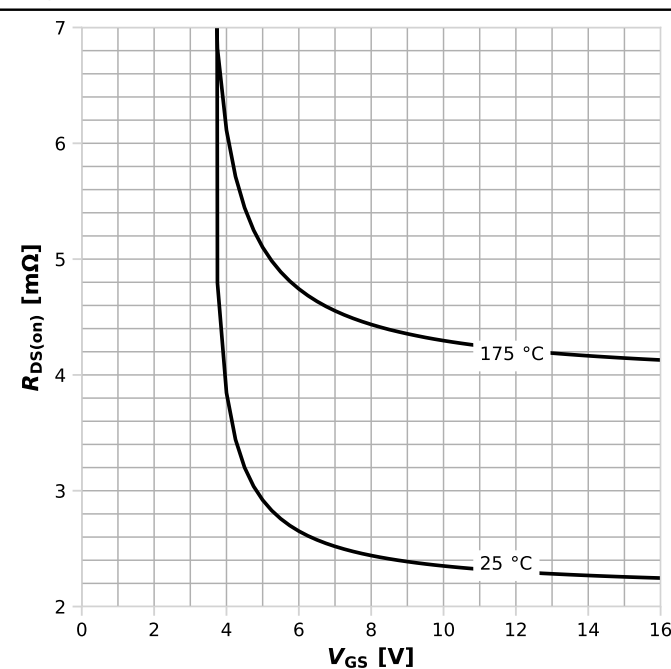
$R_{DS(on)} = f(I_D)$ ,  $T_j = 25^\circ\text{C}$ ; parameter:  $V_{GS}$

Diagram 7: Typ. transfer characteristics



$I_D = f(V_{GS})$ ,  $|V_{DS}| > 2|I_D|R_{DS(on)\max}$ ; parameter:  $T_j$

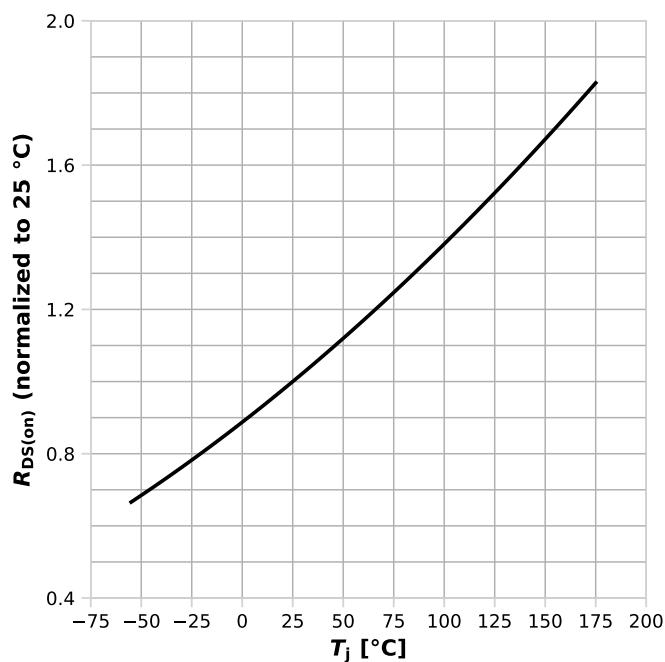
Diagram 8: Typ. drain-source on resistance



$R_{DS(on)} = f(V_{GS})$ ,  $I_D = 50\text{ A}$ ; parameter:  $T_j$

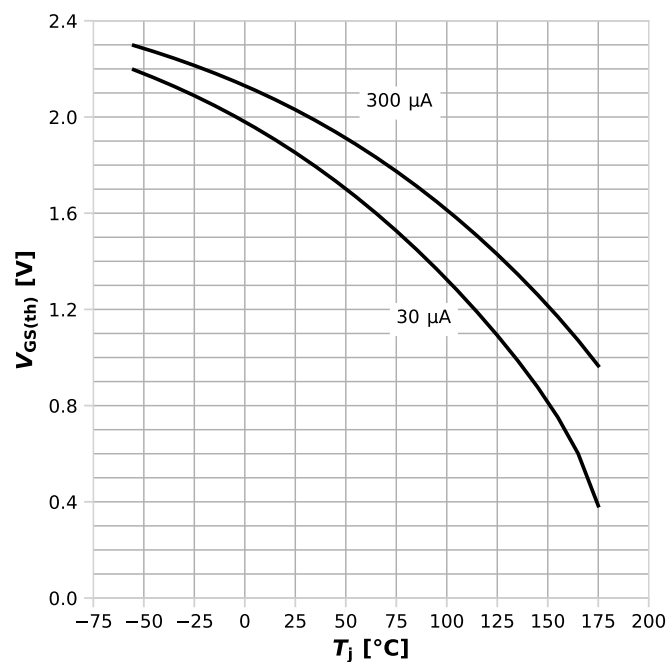


**Diagram 9: Normalized drain-source on resistance**



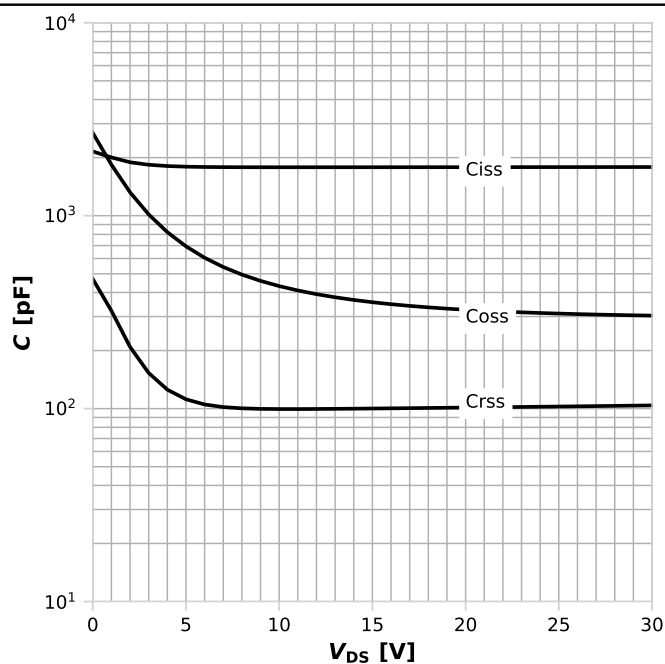
$$R_{DS(on)} = f(T_j), I_D = 50 \text{ A}, V_{GS} = 10 \text{ V}$$

**Diagram 10: Typ. gate threshold voltage**



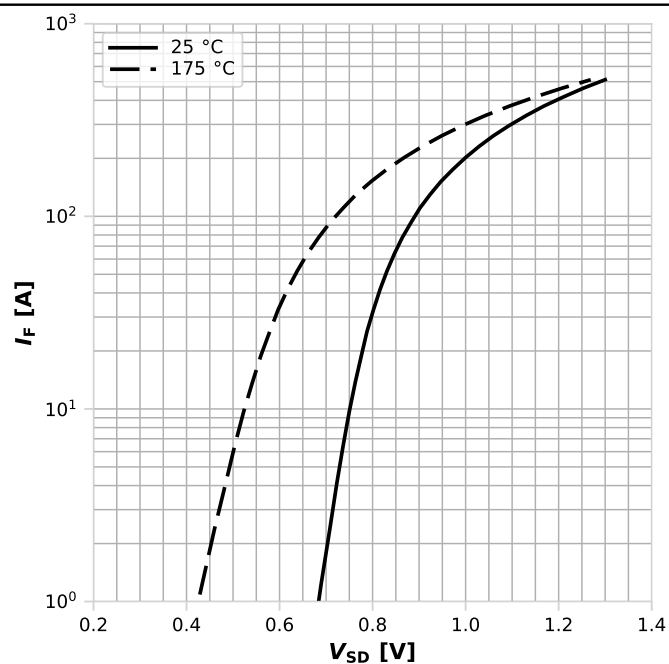
$$V_{GS(th)} = f(T_j), V_{GS} = V_{DS}; \text{ parameter: } I_D$$

**Diagram 11: Typ. capacitances**

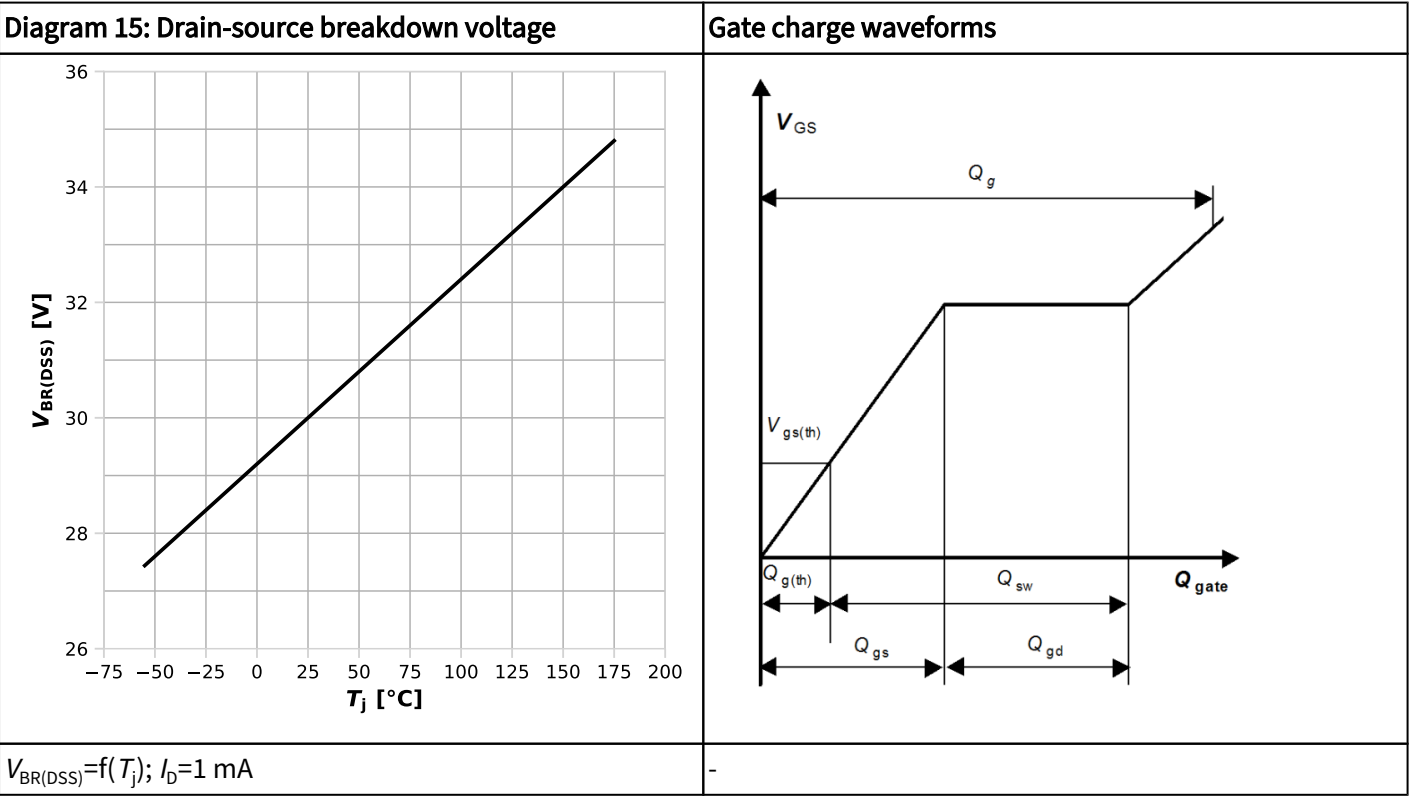
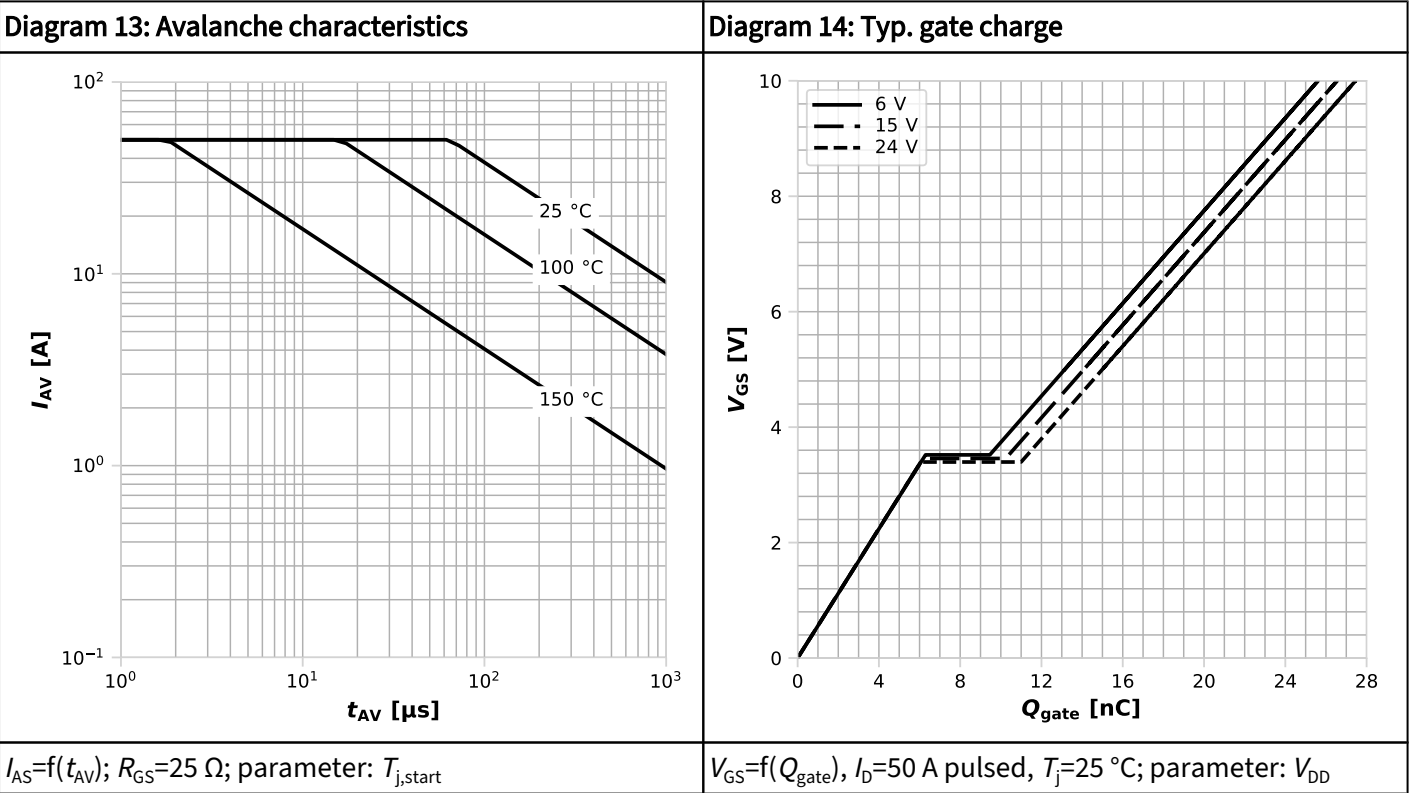


$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$

**Diagram 12: Forward characteristics of reverse diode**



$$I_F = f(V_{SD}); \text{ parameter: } T_j$$



## 5 Package outlines

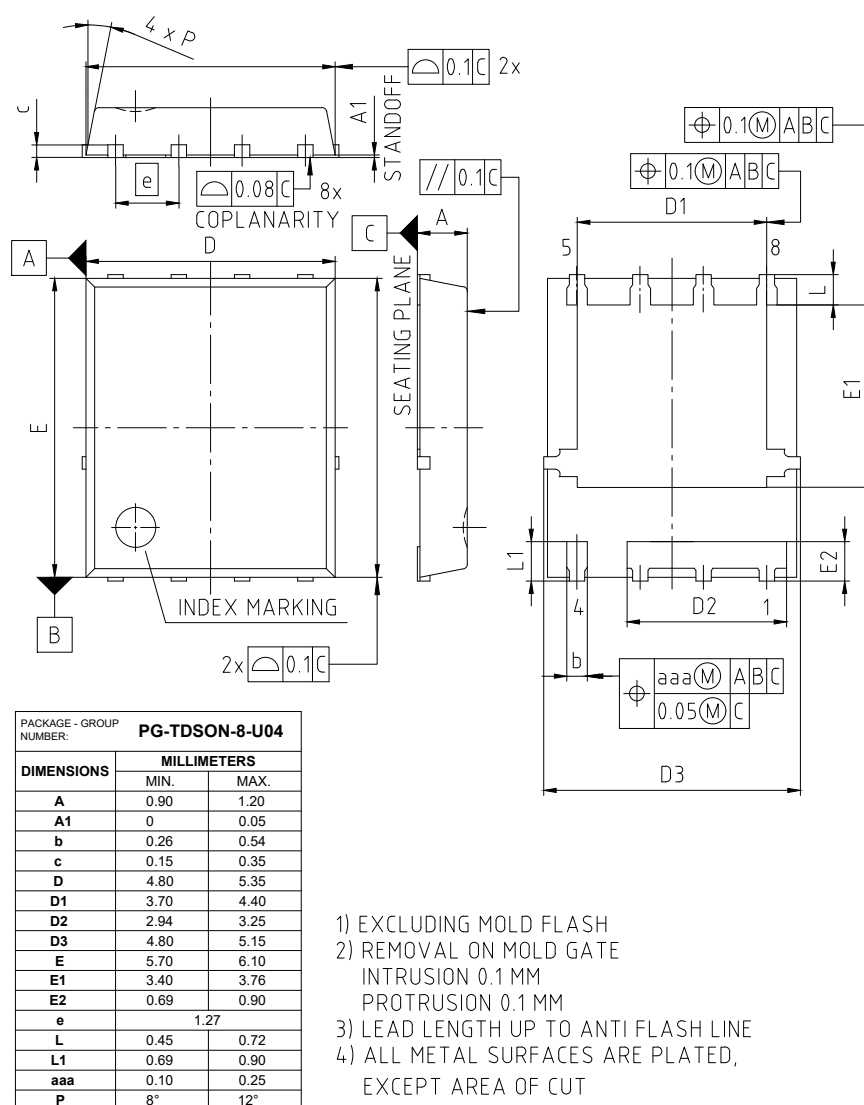
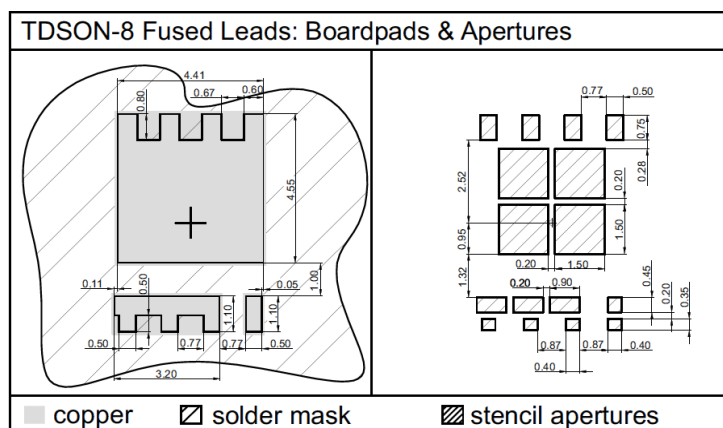
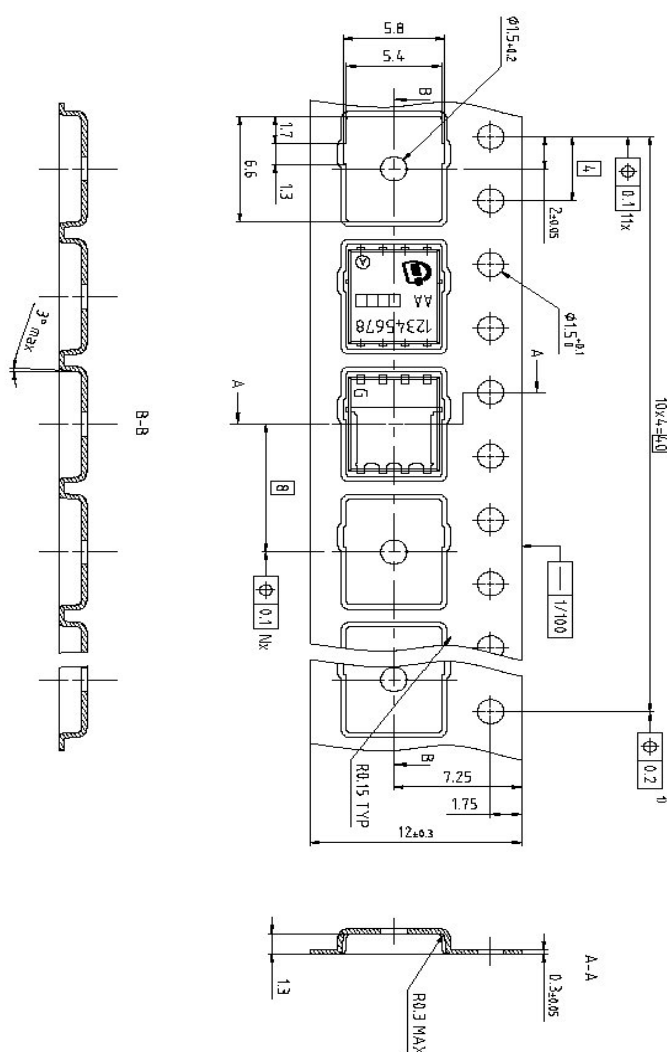


Figure 1 Outline PG-TDSON-8, dimensions in mm



**Figure 2** Footprint drawing PG-TDSON-8, dimensions in mm



**Figure 3** Packaging variant PG-TDSON-8, dimensions in mm

## Revision history

ISC028N03LF2S

### Revision 2024-11-25, Rev. 1.1

Previous revisions

Revision	Date	Subjects (major changes since last revision)
1.0	2024-10-19	Release of final
1.1	2024-11-25	updated Package outline

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